2020 15th International Microsystems, Packaging, **Assembly and Circuits Technology Conference** (IMPACT 2020)

Taipei, Taiwan 21 – 23 October 2020



**IEEE Catalog Number: CFP2059B-POD ISBN:** 

978-1-7281-9852-1

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 IEEE Catalog Number:
 CFP2059B-POD

 ISBN (Print-On-Demand):
 978-1-7281-9852-1

 ISBN (Online):
 978-1-7281-9851-4

ISSN: 2150-5934

## **Additional Copies of This Publication Are Available From:**

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Shih-Kang Lin, National Cheng Kung University

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Joshua Chao, C &C Business and Technology Ltd

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Alex King, Taimide

Joshua Chao, C &C Business and Technology Ltd

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